EH2945TS-18.432M

Series -

Moisture Sensitivity

Solderability

Vibration

Resistance to Solvents

Temperature Cycling

Resistance to Soldering Heat



EH29 45

RoHS Compliant (Pb-free) 1.8V 4 Pad 5mm x 7mm Ceramic SMD LVCMOS Oscillator

Frequency Tolerance/Stability ±50ppm Maximum

TS -18.432M Nominal Frequency

Pin 1 Connection Tri-State (High Impedance)

18.432MHz

Operating Temperature Range -0°C to +70°C

J-STD-020, MSL 1

MIL-STD-202, Method 215

MIL-STD-883, Method 2003

MIL-STD-202, Method 210, Condition K

MIL-STD-883, Method 1010, Condition B

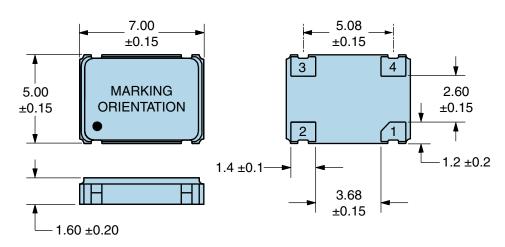
MIL-STD-883, Method 2007, Condition A

Duty Cycle 50 ±10(%)

| quency Stability over the irst Year Aging at 25°, |
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| Disable Output (High |
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EH2945TS-18.432M

MECHANICAL DIMENSIONS (all dimensions in millimeters)



| PIN | CONNECTION | |
|--------------|--|--|
| 1 | Tri-State | |
| 2 | Case Ground | |
| 3 | Output | |
| 4 | Supply Voltage | |
| LINE MARKING | | |
| 1 | ECLIPTEK | |
| 2 | 18.432M | |
| 3 | XXXXXX XXXXX=Ecliptek Manufacturing Identifier | |

Suggested Solder Pad Layout

All Dimensions in Millimeters



All Tolerances are ±0.1



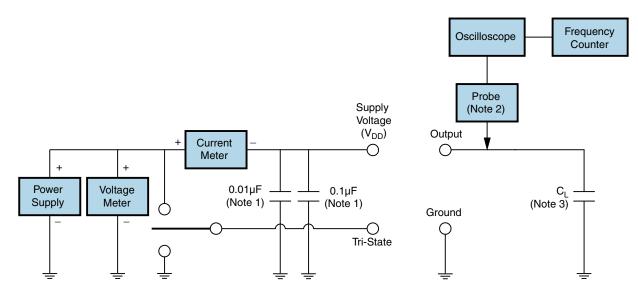
EH2945TS-18.432M



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output

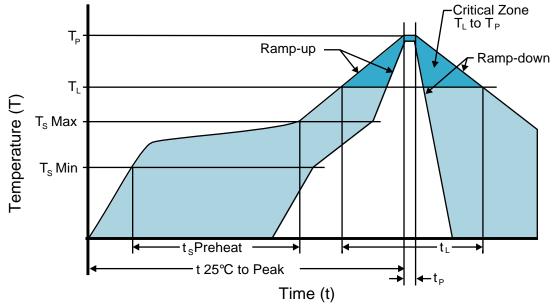


- Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less than 2mm) to the package ground and supply voltage pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value C_L includes sum of all probe and fixture capacitance.

ECLIPTEK CORPORATION

Recommended Solder Reflow Methods



High Temperature Infrared/Convection

EH2945TS-18.432M

| T _s MAX to T _L (Ramp-up Rate) | 3°C/second Maximum |
|---|---|
| Preheat | |
| - Temperature Minimum (T _s MIN) | 150°C |
| - Temperature Typical (T _s TYP) | 175°C |
| Temperature Maximum (T_s MAX) | 200°C |
| - Time (t _s MIN) | 60 - 180 Seconds |
| Ramp-up Rate (T⊾ to T _P) | 3°C/second Maximum |
| Time Maintained Above: | |
| - Temperature (T∟) | 217°C |
| - Time (t∟) | 60 - 150 Seconds |
| Peak Temperature (T _P) | 260°C Maximum for 10 Seconds Maximum |
| Target Peak Temperature (T _P Target) | 250°C +0/-5°C |
| Time within 5°C of actual peak (t _P) | 20 - 40 seconds |
| Ramp-down Rate | 6°C/second Maximum |
| Time 25°C to Peak Temperature (t) | 8 minutes Maximum |
| Moisture Sensitivity Level | Level 1 |
| Additional Notes | Temperatures shown are applied to body of device. |
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ECLIPTEK CORPORATION

Recommended Solder Reflow Methods

EH2945TS-18.432M



Low Temperature Infrared/Convection 240°C

| T _s MAX to T _L (Ramp-up Rate) | 5°C/second Maximum |
|---|--|
| Preheat | |
| - Temperature Minimum (T _s MIN) | N/A |
| Temperature Typical (T_s TYP) | 150°C |
| Temperature Maximum (T_s MAX) | N/A |
| - Time (t _s MIN) | 60 - 120 Seconds |
| Ramp-up Rate (T⊾ to T _P) | 5°C/second Maximum |
| Time Maintained Above: | |
| - Temperature (T∟) | 150°C |
| - Time (t∟) | 200 Seconds Maximum |
| Peak Temperature (T _P) | 240°C Maximum |
| Target Peak Temperature (T _P Target) | 240°C Maximum 1 Time / 230°C Maximum 2 Times |
| Time within 5°C of actual peak (t _P) | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate | 5°C/second Maximum |
| Time 25°C to Peak Temperature (t) | N/A |
| Moisture Sensitivity Level | Level 1 |
| Additional Notes | Temperatures shown are applied to body of device. |
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Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)